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INTERNATIONAL STANDARD

NORME INTERNATIONALE



High-voltage test techniques for low-voltage equipment – Definitions, test and procedure requirements, test equipment

Techniques des essais à haute tension pour matériel à basse tension – Définitions, exigences et modalités relatives aux essais, matériel d'essai





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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

HIGH-VOLTAGE TEST TECHNIQUES FOR LOW-VOLTAGE EQUIPMENT -

Definitions, test and procedure requirements, test equipment

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International Standard IEC 61180 has been prepared by IEC technical committee 42: High-voltage and high-current test techniques.

This 1st edition of IEC 61180 cancels and replaces the 1st edition of IEC 61180-1, issued in 1992, and the 1st edition of IEC 61180-2, issued in 1994.

The text of this standard is based on the following documents:

FDIS	Report on voting
42/341/FDIS	42/342/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

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HIGH-VOLTAGE TEST TECHNIQUES FOR LOW-VOLTAGE EQUIPMENT -

Definitions, test and procedure requirements, test equipment

1 Scope

This International Standard is applicable to:

- dielectric tests with direct voltage;
- dielectric tests with alternating voltage;
- dielectric tests with impulse voltage;
- test equipment used for dielectric tests on low-voltage equipment.

This standard is applicable only to tests on equipment having a rated voltage of not more than 1 kV a.c. or 1,5 kV d.c.

This standard is applicable to type and routine tests for objects which are subjected to high voltage tests as specified by the technical committee.

The test equipment comprises a voltage generator and a measuring system. This standard covers test equipment in which the measuring system is protected against external interference and coupling by appropriate screening, for example a continuous conducting shield. Therefore, simple comparison tests are sufficient to ensure valid results.

This standard is not intended to be used for electromagnetic compatibility tests on electric or electronic equipment

NOTE Tests with the combination of impulse voltages and currents are covered by IEC 61000-4-5.

This standard provides the relevant technical committees as far as possible with:

- defined terms of both general and specific applicability;
- general requirements regarding test objects and test procedures;
- methods for generation and measurement of test voltages;
- test procedures;
- methods for the evaluation of test results and to indicate criteria for acceptance;
- requirements concerning approved measuring devices and checking methods;
- measurement uncertainty.

Alternative test procedures may be required and these should be specified by the relevant technical committees.

Care should be taken if the test object has voltage limiting devices, as they may influence the results of the test. The relevant technical committees should provide guidance for testing objects equipped with voltage limiting devices.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For

undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60060-1:2010, High-voltage test techniques – Part 1: General definitions and test requirements

IEC 60060-2:2010, High-voltage test techniques – Part 2: Measuring systems

IEC 60068-1:2013, Environmental testing – Part 1: General and guidance

IEC 60335(all parts): Household and similar electrical appliances – Safety

IEC 60664-1:2007, Insulation co-ordination for equipment within low-voltage systems – Part 1: Principles, requirements and tests

IEC 61083-1:2001, Instruments and software used for measurement in high-voltage impulse test – Part 1: Requirements for instruments

IEC 61083-2:2013, Instruments and software used for measurement in high-voltage and high-current tests – Part 2: Requirements for software for tests with impulse voltages and currents

ISO/IEC Guide 98-3:2008, Uncertainty of measurement – Part 3: Guide to the expression of uncertainty in measurements (GUM)

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1 General terms

3.1.1

clearance

distance between two conductive parts along a string stretched across the shortest path between these conductive parts

[SOURCE: IEC 60050-441:1984, 441-17-31]

3.1.2

creepage distance

shortest distance along the surface of a solid insulating material between two conductive parts

[SOURCE: IEC 60050-151: 2001, 151-15-50]

3.2 Definitions related to disruptive discharge and test voltages

3.2.1

disruptive discharge

failure of insulation under electric stress, in which the discharge completely bridges the insulation under test, reducing the voltage between electrodes to practically zero

3.2.2

withstand voltage

specified voltage value which characterizes the insulation of the object with regard to a withstand test

Note 1 to entry: Unless otherwise specified, withstand voltages are referred to standard reference atmospheric conditions (see 4.2).

3.3 Characteristics related to the test equipment

3.3.1

calibration

set of operations that establishes, by reference to standards, the relationship which exists, under specified conditions, between an indication and a result of a measurement

Note 1 to entry: The determination of the scale factor is included in the calibration.

[SOURCE: IEC 60050-311:2001, 311-01-09, modified: note modified]

3.3.2

type test

conformity test made on one or more items representative of the production

Note 1 to entry: For a measuring system, this is a test performed on a component or on a complete measuring system of the same design to characterize it under operating conditions.

[SOURCE: IEC 60050-151: 2001, 151-16-16, modified:note added]

3.3.3

routine test

conformity test made on each individual item during or after manufacture

Note 1 to entry: This is a test performed on each component or on each complete measuring system to characterize it under operating conditions.

[SOURCE: IEC 60050-151: 2001, 151-16-17, modified:note added]

3.3.4

performance test

test performed on a complete measuring system to characterize it under operating conditions

3.3.5

test equipment

complete set of devices needed to generate and measure the test voltage or current applied to a test object

3.3.6

reference measuring system

measuring system with its calibration traceable to relevant national and/or international standards, and having sufficient accuracy and stability for use in the approval of other systems by making simultaneous comparative measurements with specific types of waveform and ranges of voltage

3.3.7

assigned scale factor

scale factor of a measuring system determined at the most recent performance test

Note 1 to entry: A measuring system may have more than one assigned scale factor; for example, it may have several ranges, each with a different scale factor.

3.4 Characteristics related to direct voltage tests

3.4.1

value of the test voltage

arithmetic mean value